

Search Notes

Application/Control No.

10/784,292

Examiner

KIEU-OANH T. BUI

Applicant(s)/Patent under
Reexamination

NISHIOKA ET AL.

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	38,40,51, 52,55,110, 112,115,	5/17/2006	KB
	116,145,		
	146,151		
348	569		
709	219		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
725	38,51,110	5/17/2006	KB
	112,151		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search 725 and text 348, 709	5/17/2006	KB